



US 20060017679A1

(19) **United States**(12) **Patent Application Publication** (10) **Pub. No.: US 2006/0017679 A1**
(43) **Pub. Date: Jan. 26, 2006**
Hirakata et al.(54) **DRIVING METHOD OF ACTIVE MATRIX
DISPLAY DEVICE**(30) **Foreign Application Priority Data**

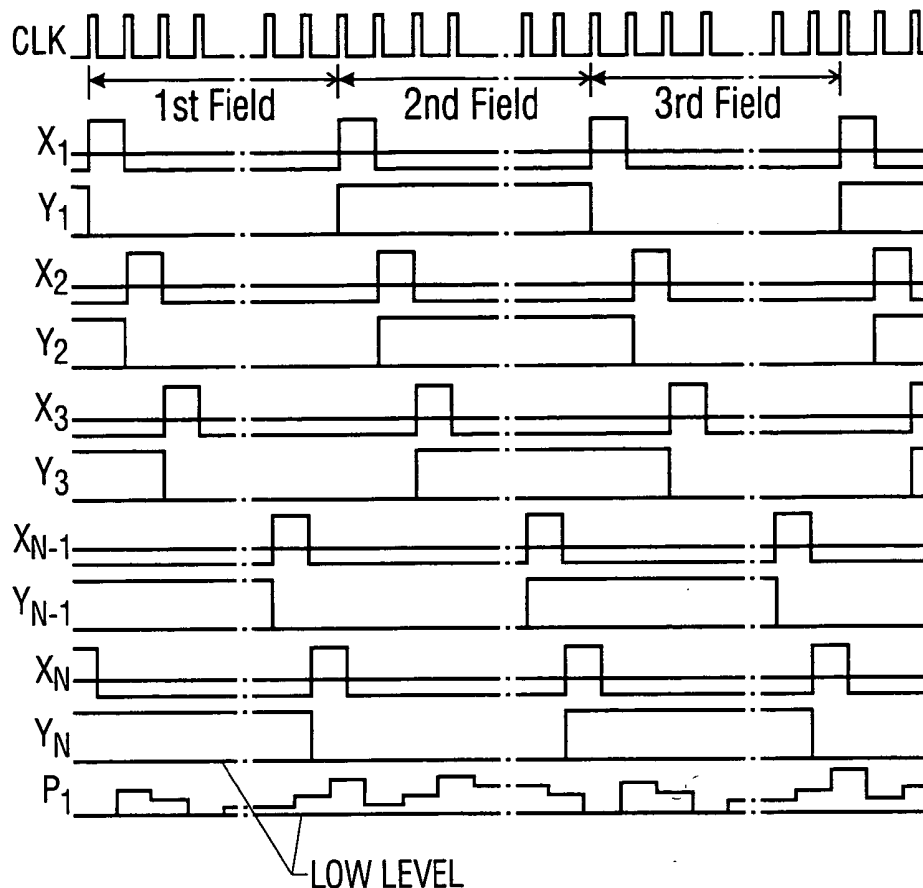
Mar. 26, 1996 (JP) 8-096317

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G09G 3/36 (2006.01)
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MINNEAPOLIS, MN 55440-1022 (US)(57) **ABSTRACT**

In a liquid crystal display device of the in-plane switching mode (IPS mode), the potential of data that is output from a data driver is set at values between potentials that are given to common lines. Two levels, i.e., high and low levels, are prepared for the potential to be given to the common lines and the potential is inverted between those levels in every field, whereby the polarity of a voltage between both electrodes of a pixel is inverted. As a result, the potential variation ranges of signals that are output from the data driver and a scan driver can be greatly reduced from those of the conventional case, which contributes to reduction in the power consumption of the drivers. Since the voltage applied to a switching element for controlling each pixel can be reduced, the load of the switching element can also be reduced.

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Co., Ltd.**, a JAPAN corporation(21) Appl. No.: **11/166,339**(22) Filed: **Jun. 27, 2005****Related U.S. Application Data**

(63) Continuation of application No. 09/206,653, filed on Dec. 7, 1998, now Pat. No. 6,911,962, which is a continuation of application No. 08/823,238, filed on Mar. 24, 1997, now Pat. No. 5,847,687.



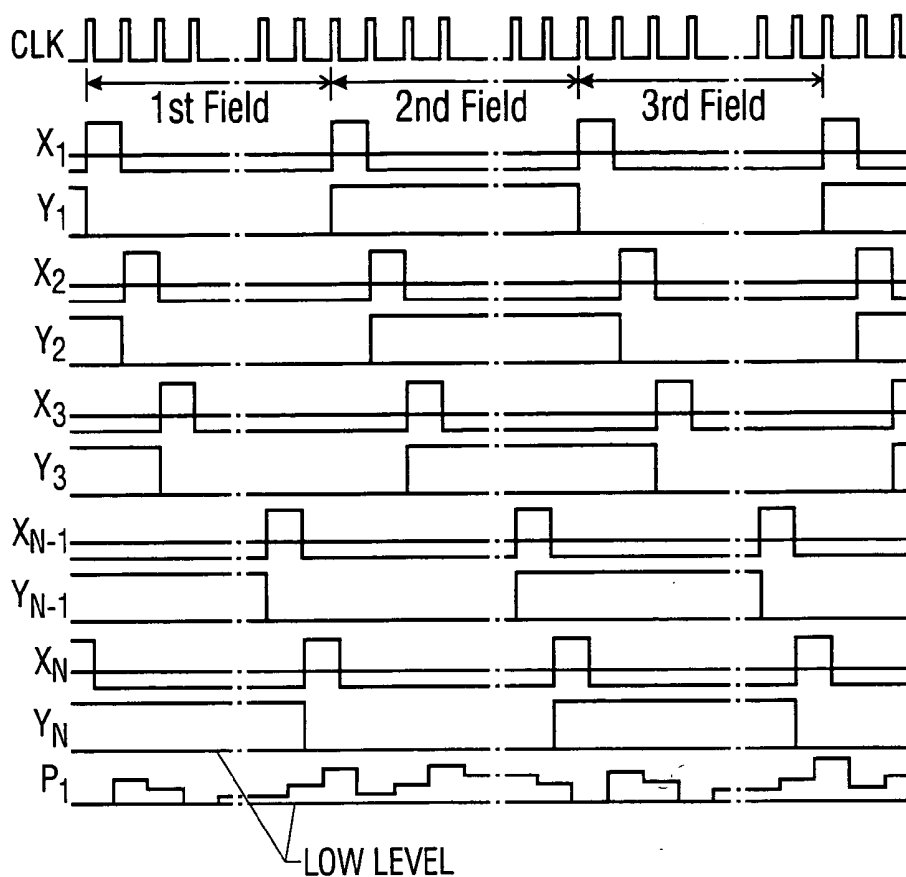


FIG. 1

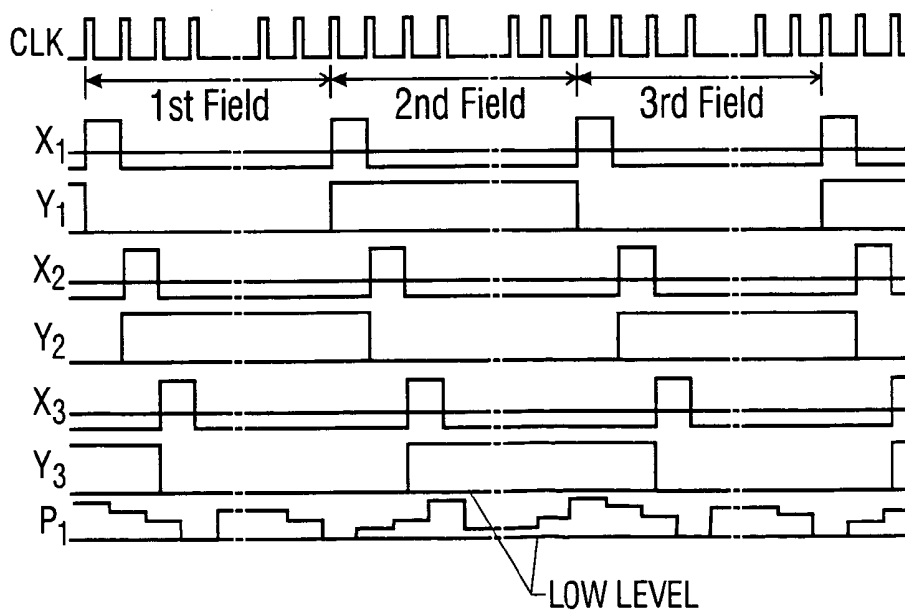


FIG. 2

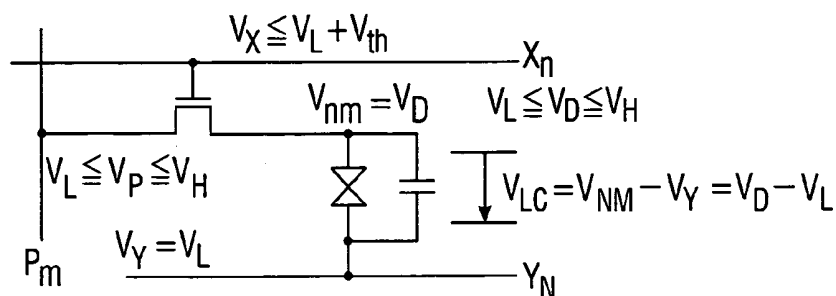


FIG. 3A

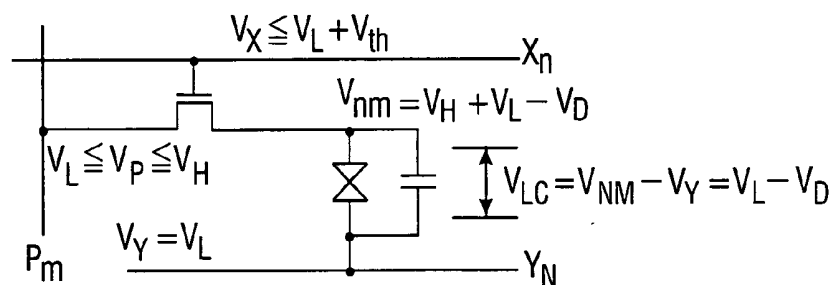


FIG. 3B

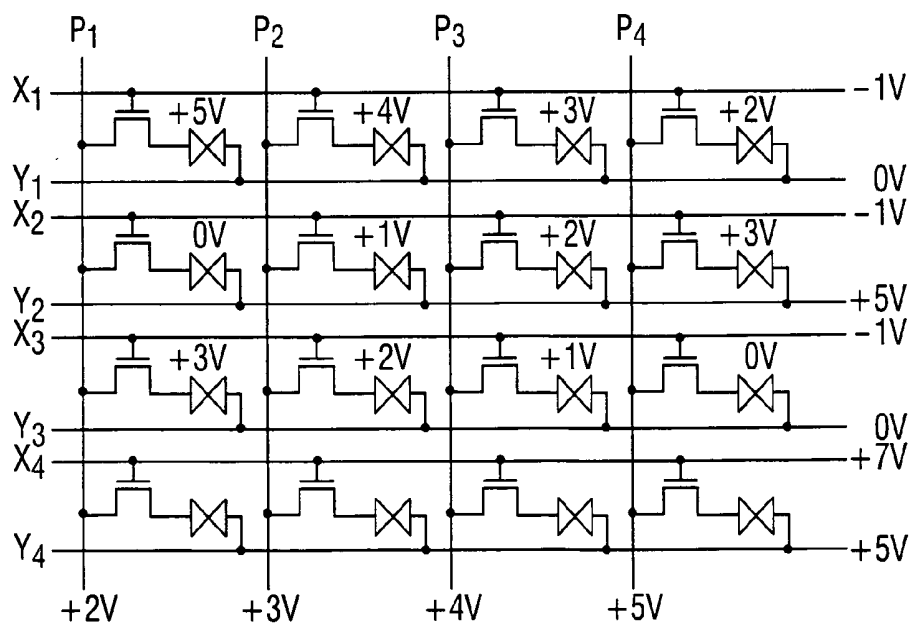


FIG. 4

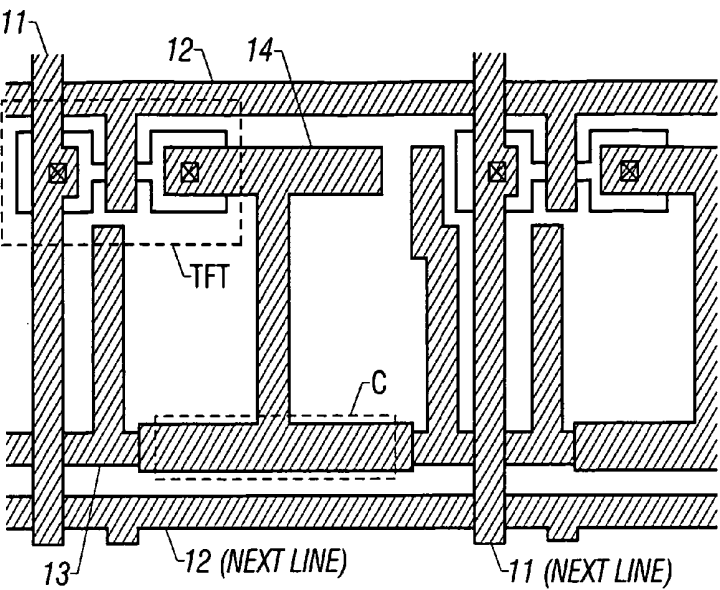


FIG. 5
(Prior Art)

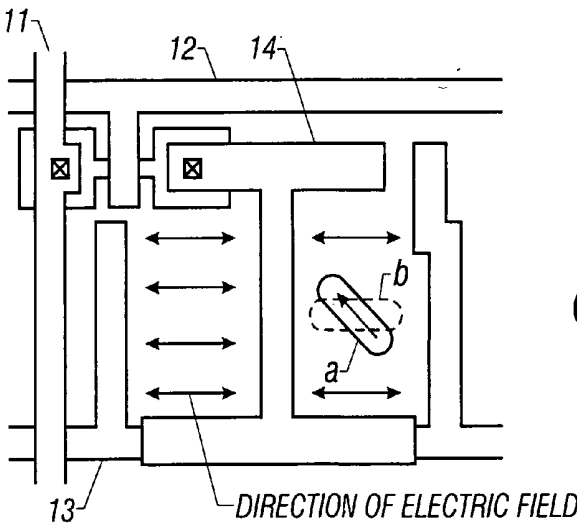


FIG. 6
(Prior Art)

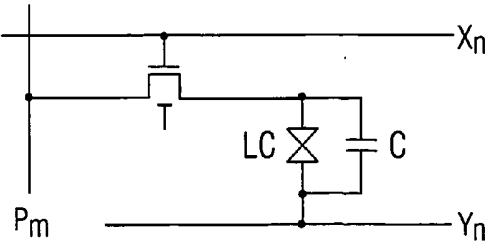


FIG. 7
(Prior Art)

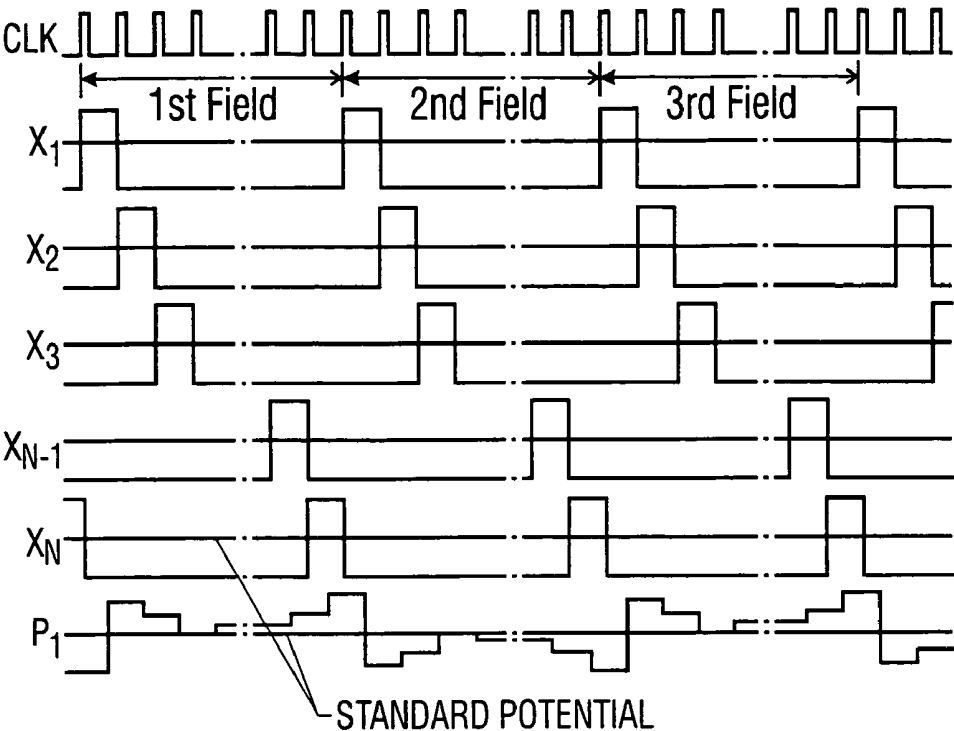


FIG. 8
(Prior Art)

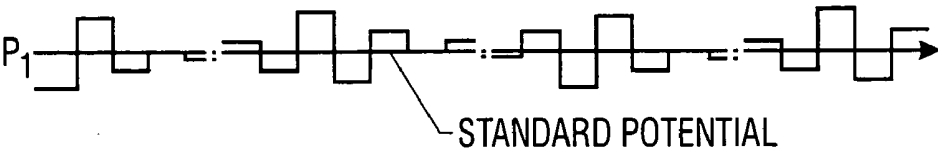


FIG. 9
(Prior Art)

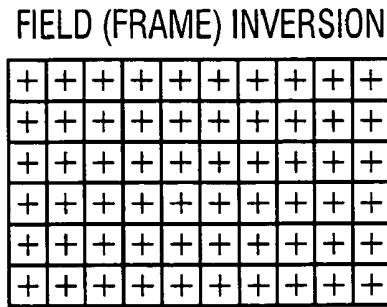


FIG. 10A
(Prior Art)

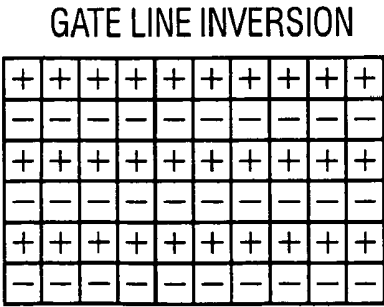


FIG. 10B
(Prior Art)

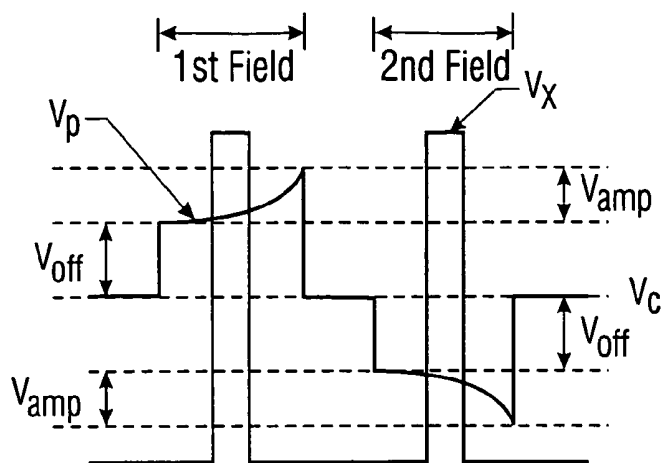


FIG. 11A
(Prior Art)

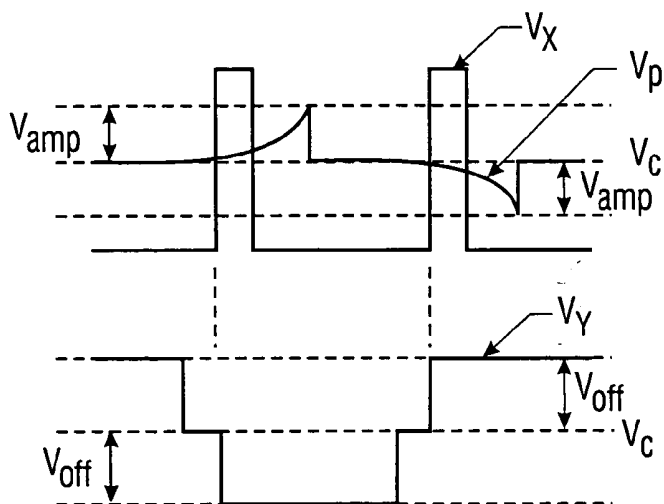


FIG. 11B

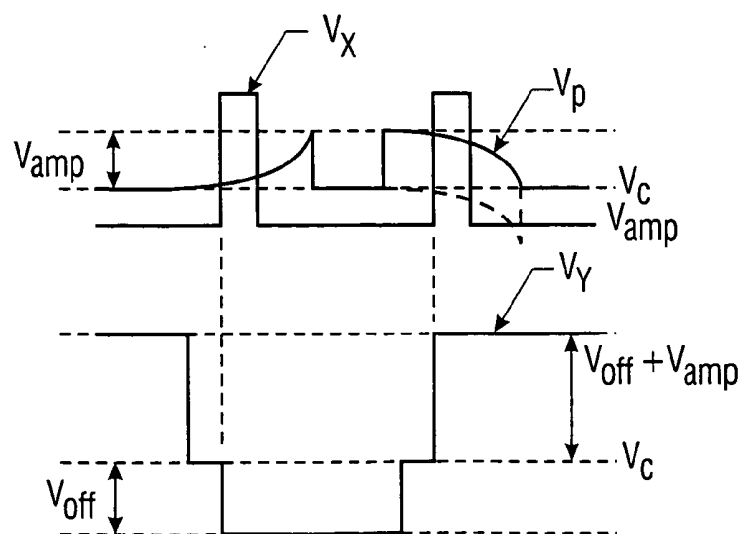


FIG. 11C

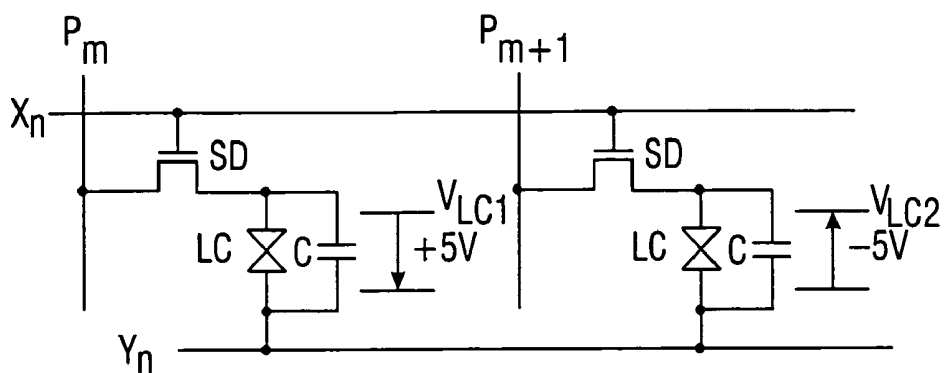


FIG. 12A

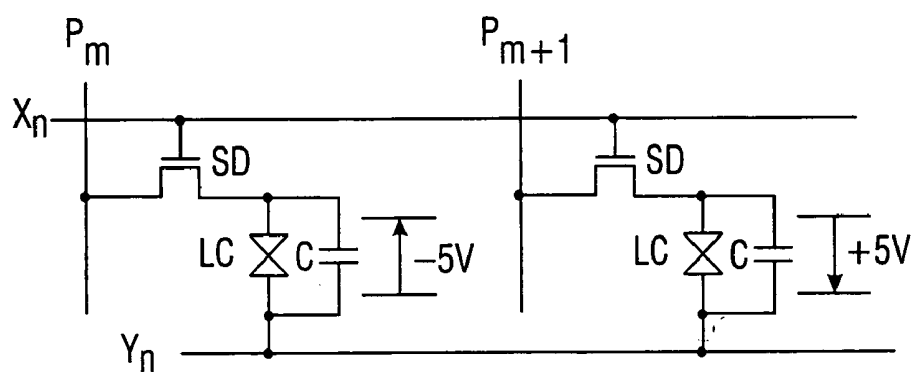


FIG. 12B

	FIRST FIELD	NEXT FIELD
P_m	+5V	0V
P_{m+1}	-5V	0V
Y_n	0V	+5V
V_{LC1}	+5V	-5V
V_{LC2}	-5V	+5V

$$V_{LC1} = P_m - Y_n \quad V_{LC2} = P_{m+1} - Y_n$$

FIG. 12C

DRIVING METHOD OF ACTIVE MATRIX DISPLAY DEVICE

BACKGROUND OF THE INVENTION

[0001] 1. Field of the Invention

[0002] The present invention relates to an active matrix display device. In particular, the invention relates to an active matrix display device which employs a display method of the in-plane switching mode (also called IPS mode). The invention is intended to reduce potential variation of signals (or data) to thereby lower the power consumption, and to reduce voltages applied to the switching elements that are provided for the respective pixels to thereby lower the loads of the switching elements. The invention also relates to a driving method of a capacitive-coupling-type display device such as a liquid crystal display device.

[0003] 2. Description of Related Art

[0004] In a capacitive-coupling-type display device such as a liquid crystal display device, it is necessary to invert the polarity of a voltage applied to a pixel capacitor element. This operation is also called alternating. This is because if electric fields in one direction are always applied to an electro-optical material (a material whose optical property such as light transmittance, reflectance, or a refractive index varies depending on the voltage applied thereto) provided between the electrodes of a capacitor element, the material will deteriorate. It is necessary to invert the polarity of the voltage every field (or frame) or every several fields.

[0005] Among various inverting methods, there are a field (or frame) inverting scheme in which the polarity is the same over the entire display screen in each field (see FIG. 10A), and a gate line inverting scheme in which the polarity of each row is different from adjacent rows, (see FIG. 10B). The above methods can be applied to the IPS mode.

[0006] Conventionally, the polarity inversion is performed such that each pixel is supplied, from a data driver (signal driver), with a signal whose polarity is inverted. FIG. 7 shows a unit pixel of a conventional active matrix liquid crystal display device. A thin-film transistor T as a switching element is controlled by a signal (selection pulses) on a scan line X_n . In a state that a selection pulse is applied to the thin-film transistor T (on-state), a signal on a data line (signal line) P_m is supplied to a liquid crystal pixel element LC and, if necessary, to an auxiliary capacitor C connected in parallel with the pixel element. On the other hand, the potential of a common line (or common electrode) Y_n is kept constant. Charge is stored in accordance with a difference between the potential supplied from the data line P_m and that of the common line Y_n .

[0007] FIG. 8 shows drive signals in a display device in which such unit pixels are arranged in an N-row matrix. In FIG. 8, a clock signal (sync signal) CLK indicates a minimum operation time of the display device. Signals are generated based on the clock signal CLK. As shown in FIG. 8, selection pulses are sequentially applied to scan lines $X_1, X_2, X_3, \dots, X_{N-1}, X_N$. On the other hand, potentials depending on image signals for the respective rows are applied to a data line P_1 . This example is directed to the field inverting scheme (FIG. 10A). For convenience of comparison, it is assumed that the image information of the fields are

always the same; that is, the data of the second field is an inversion of that of the first field with respect to the reference potential (i.e., the potential of the common lines). The same relationship exists between the second and third fields.

[0008] FIG. 9 shows an example of data in the case of the gate line inverting scheme (FIG. 10B). The data for each row has opposite polarities between the first and second fields.

[0009] As described above, in the conventional active matrix liquid crystal display devices, the driver needs to generate data whose variation range is two times that of a signal required by only image information. That is, although basically it is sufficient to apply a liquid crystal with effective voltages of a 5 V, the necessity of inversion requires a variation range of 10 V, i.e., +5 V to -5 V. This increases drive voltages of the driver, and hence is the greatest obstacle to reduction in power consumption.

[0010] There is another problem because of the increase of large potential variations of data, output potential differences (i.e., selection pulse heights) of the scan driver, and power consumption therein. Further, due to large voltages applied to the active matrix circuit, the switching elements (transistors) will possibly be broken or their characteristics will possibly deteriorate.

[0011] The present invention has been made in view of the above problems, and an object of the invention is therefore to provide a device configuration and a corresponding driving method which enable necessary polarity inversion while minimizing data variations.

[0012] In the in-plane switching (IPS) mode, a display is performed by applying electric fields of which directions are parallel with a substrate surface by means of a single substrate, in contrast to the conventional liquid crystal display devices in which display is performed by applying, between the substrates, electric fields perpendicular to the substrates. Japanese Examined Patent Publication No. Sho. 63-21907 discloses the basic concept of the IPS mode in an active matrix liquid crystal display device using thin-film transistors as switching elements.

[0013] Among the inventions made by adapting the above basic concept of the IPS mode are disclosed in Japanese Unexamined Patent Publication Nos. Hei. 7-43744, Hei. 7-43716, Hei. 7-36058, Hei. 6-160878, Hei. 6-202073, Hei. 7-134301, and Hei. 6-214244. Further, Japanese Unexamined Patent Publication No. Hei. 7-72491 is directed to a case where the IPS mode is used in a passive matrix liquid crystal display device. Japanese Unexamined Patent Publication No. Hei. 7-120791 is directed to a case where the IPS mode is employed in an active matrix liquid crystal display device using thin-film diodes as switching elements.

[0014] The operation principle of the IPS mode disclosed in the above prior art references will be briefly described below with reference to FIGS. 5 and 6. FIG. 5 shows a unit pixel of an active matrix liquid crystal display device using the IPS mode. As in the case of ordinary active matrix liquid crystal display devices, data lines 11 and scan lines 12 are arranged in matrix form. In addition, common lines (also called opposed electrode lines) 13 are provided.

[0015] Conventionally, the common lines 13 are not necessary in the substrate because the opposed substrate has

them. However, in the IPS mode in which the opposed substrate has no electrode, wiring lines (i.e., common lines **13**) having a function equivalent to that of the above electrode need to be provided on the substrate concerned.

[0016] In the conventional IPS mode, the potential of the common lines **13** is kept at a constant value. Where the common lines **13** are formed at the same time as the scan lines **12**, the former is patterned so as not to intersect the latter, that is, so as to be parallel with the latter. With this structure, the common line **13** may be overlapped with a pixel electrode **14** which is formed at the same time as the data line **11**, to form an auxiliary electrode C.

[0017] That is, the scan lines **12** and the common lines **13** can be formed at the same time and the data lines **11** and the pixel electrodes **14** can also be formed at the same time. A switching element (thin-film transistor, i.e., TFT) is formed as shown in **FIG. 5** with a portion of the scan line **12** used as a control electrode (i.e., gate electrode). The input terminal (source) of the switching element is in contact with the data line **11** and the output terminal (drain) is in contact with one electrode (pixel electrode **14**) of the pixel capacitor element. The common line **13** serves as the other electrode of the pixel capacitor element.

[0018] In **FIG. 6**, since the common line **13** is so formed as to be opposed to the pixel electrode **14** as described above, when a potential is given to the pixel electrode **14**, electric fields indicated by arrows develop between the pixel electrode **14** and the common line **13**. Where a liquid crystal is used as the electro-optical material, in the initial state liquid crystal molecules are so oriented as to form a predetermined angle with expected electric fields (state a in **FIG. 6**). For example, in the case of a nematic liquid crystal, the predetermined angle is 15° . When electric fields are applied, liquid crystal molecules tend to become parallel with the electric field (state b in **FIG. 6**). Gradation can be expressed by properly utilizing the inclination of liquid crystal molecules. The description of the operation principle of the IPS mode concludes here.

[0019] The IPS mode has a feature of a wider viewing angle than in the conventional liquid crystal display devices because the liquid crystal is oriented parallel with the substrates. However, in the above-described prior art of the IPS mode, no consideration is made of reduction in the load of the data driver; data are generated in the same manner as in the conventional cases.

SUMMARY OF THE INVENTION

[0020] According to the present invention, with keeping the feature of the IPS mode, it is able to reduce the potential variation range of data while inverting the direction of electric fields applied to liquid crystal molecules. The invention is directed to a configuration in which the common lines and the scan lines are arranged so as not to cross each other and the potential of each common line can be controlled in accordance with a signal supplied to the corresponding scan line. The invention is characterized in that each common line is given a potential V_H or V_L ($V_H > V_L$) during almost all of a period when a selection pulse is not applied to the corresponding scan line, and that each pixel electrode is given a signal potential V_D ($V_L \leq V_D \leq V_H$) in accordance with image information.

[0021] Naturally, a potential other than V_H and V_L (for instance, a middle value thereof or a value larger than the middle value) may be given to the common lines in a very short period (short enough not to affect an image; for instance, immediately before or after application of a selection pulse).

[0022] To avoid affecting an image, the period during which a potential other than V_H and V_L is applied should be shorter than 20% of one field period, preferably shorter than 5% thereof. That is, the common lines should be kept at the potential V_H or V_L during 80% or more of one field period, preferably 95% or more thereof.

[0023] In the invention, in a case where inversion is performed every field, the potential of each common line in a certain field may be set different from that of immediately preceding and following fields.

[0024] Since the potential of each common line needs to be kept constant until another signal is input next via the switching element, it may be changed to another value every time a pulse signal is applied to the corresponding scan line.

[0025] The invention can be applied to both of the field inverting scheme and the gate line inverting scheme. In the latter case, the potentials of adjacent common lines may be set always different from each other.

[0026] Where the invention is applied to a liquid crystal display device, it is preferred that the potential given to each common line be lower than the threshold voltage of a liquid crystal, to avoid affecting an image.

[0027] When the voltage applied to a liquid crystal is increased from 0 V, the major axes of liquid crystal molecules are rotated at a time point when the voltage exceeds a certain value. This voltage value is called the threshold voltage of the liquid crystal.

[0028] Therefore, even if the potentials of the common lines vary, disorder in the alignment of the liquid crystal, and resulting influences on an image are prevented by making the absolute values of the potentials given to the common lines smaller than the threshold voltage of the liquid crystal.

BRIEF DESCRIPTION OF THE DRAWINGS

[0029] **FIG. 1** shows a field inverting type driving method according to a first embodiment of the present invention;

[0030] **FIG. 2** shows a gate line inverting type driving method according to a second embodiment of the invention;

[0031] **FIGS. 3A and 3B** show the operation principle of the invention for a unit pixel;

[0032] **FIG. 4** shows potentials of part of the matrix in a certain field in the second embodiment of the invention;

[0033] **FIG. 5** shows a unit pixel in the IPS mode;

[0034] **FIG. 6** shows the operation principle of the IPS mode;

[0035] **FIG. 7** shows the configuration of a unit pixel of an active matrix liquid crystal display device;

[0036] **FIG. 8** shows the operation of a conventional active matrix liquid crystal display device (field inverting mode);

[0037] FIG. 9 shows the operation of a conventional active matrix liquid crystal display device (gate line inverting mode);

[0038] FIGS. 10A and 10B illustrate the concepts of field (or frame) inversion and gate line inversion, respectively;

[0039] FIGS. 11A-11C shows differences between a conventional driving method and a driving method according to a third embodiment of the invention; and

[0040] FIG. 12A-12C show why it is not effective to apply the invention to the source line inverting scheme.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

[0041] The operation of a unit pixel according to the present invention will be described below with reference to FIGS. 3A and 3B. A specific electrode/wiring line structure corresponding to FIGS. 3A and 3B is the same as that of the conventional active matrix display device of the IPS mode shown in FIG. 5.

[0042] Both FIGS. 3A and 3B show a state that the switching element SD is closed. Therefore, in either case, the scan line X_n is supplied with a potential for rendering the switching element SD in an off-state. Where the switching element SD is a single, n-channel transistor, the necessary and sufficient condition of such a potential V_X is $V_X \leq V_L + V_{th}$ (V_{th} is the threshold voltage of the switching element SD) for the reason described later.

[0043] In a certain field, a pixel electrode potential V_{nm} is equal to V_D, which corresponds to image information and satisfies a condition $V_L \leq V_D \leq V_H$ in any case. It goes without saying that the pixel electrode potential V_{nm} is determined by a potential V_P of the data lines P_m at a time point when the switching element SD is opened (more precisely, at an instant when it is closed). Therefore, $V_L \leq V_P \leq V_H$.

[0044] In FIG. 3A, a potential V_Y of the common line Y_n is V_L. In this state, a potential difference V_{LC} (=V_{nm}-V_Y) applied to the pixel capacitor element LC is V_D-V_L. Since $V_D \geq V_L$, the direction of an actual electric field is as indicated by the arrow.

[0045] It is assumed that in the next field the potential difference across the pixel capacitor element LC is reversed (FIG. 3B). In this field, the potential V_Y of the common line Y_n is set at V_H, and the pixel electrode potential V_{nm} is set at $V_H + V_L - V_D$. From the condition $V_L \leq V_D \leq V_H$, an inequality $V_L \leq V_H + V_L - V_D \leq V_H$ is satisfied. The potential difference V_{LC} (=V_{nm}-V_Y) applied to the pixel capacitor element LC is equal to V_L-V_D. Since $V_D \geq V_L$, the direction of an actual electric field is as indicated by the arrow in FIG. 3B. Thus, the electric field direction can be reversed.

[0046] From the equations of V_{LC} in the above two fields, the following inequalities hold:

$$\text{(First field): } V_{LC} = V_D - V_L \leq V_H - V_L$$

$$\text{(Next field): } V_{LC} = V_L - V_D \geq V_L - V_H$$

Therefore, there is the following relationship:

$$V_L - V_H \leq V_{LC} \leq V_H - V_L, \text{ or}$$

$$|V_{LC}| \leq V_H - V_L$$

[0047] That is, the magnitude of the voltage difference across the pixel capacitor element LC is $V_H - V_L$ or less. Incidentally, the above relationship is not satisfied in the conventional method because the potential of the common line Y_n does not vary, that is, $V_H = V_L = 0$ and $|V_{LC}| > 0$. The fact that the potential V_Y of the common electrode Y_n varies so as to have the above relationship satisfied is one of the features of the invention.

[0048] Next, the potential of the data line P_m will be considered. To obtain the state of FIG. 3B, the potential V_P of the data line P_m needs to be set such that $V_P = V_{nm} = V_H + V_L - V_D$. Since $V_L \leq V_H + V_L - V_D \leq V_H$, the relationship $V_L \leq V_P \leq V_H$ is satisfied also in this case. That is, when the polarity inversion is performed, the potential V_P of the data line P_m satisfies $V_L \leq V_P \leq V_H$.

[0049] Where the switching element SD is a single, n-channel transistor, to keep an off-state irrespective of the potentials of the data line and the pixel electrode, the potential V_X of the scan line (gate line) may be set lower than a potential that is the total of the threshold voltage and the lower one of the potentials of the data line and the pixel electrode. Since the minimum value that can be taken by the potentials of the data line and the pixel electrode is V_L, it is sufficient that the potential V_X of the scan line be so set as to satisfy $V_X \leq V_L + V_{th}$.

[0050] On the other hand, to obtain an on-state, the potential V_X of the scan line may be set higher than a potential that is the total of the threshold voltage and the higher one of the potentials of the data line and the pixel electrode. Since the maximum value that can be taken by the potentials of the data line and the pixel electrode is V_H, it is sufficient that the potential V_X of the scan line be so set as to satisfy $V_X \geq V_H + V_{th}$.

[0051] For example, where the maximum voltage difference applied to the pixel capacitor element LC is 5 V, V_L and V_H may be set at 0 V and +5 V, respectively, in which case the data line potential V_P satisfies $0 \leq V_P \leq 5$ V. In this manner, the voltage difference applied to the pixel capacitor element LC can have any value between -5 V and +5 V. On the other hand, it is sufficient that the scan line potential V_X be lower than V_{th} V in an on-state and higher than $(5 + V_{th})$ V in an on-state. For example, with assumptions that the threshold voltage V_{th} is +0.5 V and a margin of 1.5 V is established, the scan line potential V_X may be set at 7 V in an on-state and -1 V in an off-state.

[0052] As described above, the invention has another feature that even if the variation range of data applied to the data line (and the common line) is greatly reduced from that of the conventional case, the direction of an electric field applied to the liquid crystal capacitor element LC can still be reversed.

[0053] For example, it is able to make the potential variation range of data in half. The fact that the variation range of the potential given to the scan line (i.e., the selection pulse height) can be greatly reduced too, which is another feature of the invention. In this manner, the invention can reduce the operation voltages to a large extent.

[0054] Although the invention is effective for inverting schemes such as the field inversion and the gate line inversion in which the pixels associated with the same scan line have the same polarity, the above-described advantages

cannot be obtained in inverting schemes such as the source line inversion and the dot inversion in which the pixels associated with the same scan line have different polarities.

[0055] The source line inverting scheme is characterized in that adjacent pixel electrodes of the same row (i.e., the same scan line) have different polarities. For example, as shown in **FIGS. 12A-12C**, assume a case where potential differences V_{LC1} and V_{LC2} of two adjacent (i.e., left and right) pixels are +5 V and -5 V in the first field (**FIG. 12A**) and -5 V and +5 V in the second field (**FIG. 12B**).

[0056] Where the switching element SD is an n-channel transistor, the scan line potential is required to be lower than the minimum potential of the data line in an off-state and to be higher than the maximum potential of the data line in an on-state. In the conventional methods (see **FIGS. 8 and 9**), the potentials of both data lines P_m and P_{m+1} varies between -5 V and +5 V, i.e., over a range of 10 V. Therefore, the potential variation range of the scan line should also be 10 V.

[0057] To apply the invention to the left-side pixel, in the first field the potential of the common line Y_n and the data of the data line P_m may be set at 0 V and +5 V, respectively, and in the second field they may be set at +5 V and 0 V, respectively. As for the right-hand pixel, the data of the data line P_{m+1} may be set at -5 V in the first field and 0 V in the second field. **FIG. 12C** summarizes the above.

[0058] To effect switching under the above conditions with the assumption that the switching element is an n-channel transistor SD, the potential of the scan line X_n should be lower than -5 V (minimum potential of the data line) in an off-state and should be higher than +5 V (maximum potential of the data line) in an on-state. That is, the variation range of 10 V is still required; the invention is the same as the conventional cases in terms of the potential variation range of the scan line (i.e., the driving ability of the scan driver). The invention provides no advantage in this respect.

[0059] However, the potential variation range of each data line is 5 V, which is a half of that of the conventional cases. Thus, the invention cannot substantially reduce the voltages of the entire display circuit, but it is effective in reducing the potential variation range of each data line. Naturally, the effect of the source line inverting is less than that of the field inverting or the gate lane inverting.

[0060] Incidentally, in the invention, the common line cannot be formed in parallel with the data line because in such a case a signal on the common line would vary in accordance with the potential of the data line.

Embodiment 1

[0061] **FIG. 1** shows a field inverting type driving method according to the invention in an N-row active matrix liquid crystal display device employing the IPS mode. In this embodiment, the same display data as shown in **FIG. 8** are used. As shown in **FIG. 1**, in the first field, selection pulses are sequentially applied to N scan lines $X_1, X_2, X_3, \dots, X_{N-1}, X_N$. At a time point when a pulse is applied to each scan line, the potential of the corresponding one of the common lines $Y_1, Y_2, Y_3, \dots, Y_{N-1}, Y_N$ decreases from the high-level (V_H) to the low-level (V_L). Thus, the state of **FIG. 3A** is realized.

[0062] Conversely, in the second field, when selection pulses are sequentially applied to the scan lines $X_1, X_2, X_3, \dots, X_{N-1}, X_N$, the potentials of the corresponding common lines $Y_1, Y_2, Y_3, \dots, Y_{N-1}, Y_N$ increase from the low-level to the high-level. This the state of **FIG. 3B** is realized.

[0063] In the third field, the same operation as in the first field is performed. The direction of an electric field applied to each liquid crystal capacitor element in the first field is in inverse to that in the second field. The same relationship holds between the second field and the third field. In this embodiment, the state of **FIG. 3A** or **3B** is established in all rows in a certain field. Thus, the field inverting type driving is performed.

Embodiment 2

[0064] **FIG. 2** shows a gate line inverting type driving method according to the invention in an N-row active matrix liquid crystal display device employing the IPS mode. As shown in **FIG. 2**, in the first field, the potentials of the odd-numbered common lines $Y_1, Y_3, \dots$ are changed from the high-level to the low-level when selection pulses are applied to the corresponding scan lines. Conversely, the potentials of the even-numbered common lines $Y_2, Y_4, \dots$ are changed from the low-level to the high-level when selection pulses are applied to the corresponding scan lines.

[0065] That is, in the first field, the state of **FIG. 3A** is established in the odd-numbered rows and the state of **FIG. 3B** is established in the even-numbered rows. Thus, a gate line inverting state is attained in which the directions of electric fields applied to the liquid crystal capacitor elements LC in adjacent rows are reverse to each other.

[0066] The operation in the second field is in converse to that in the first field. The potentials of the odd-numbered common lines $Y_1, Y_3, \dots$ are changed from the low-level to the high-level while the potentials of the even-numbered common lines $Y_2, Y_4, \dots$ are changed from the high-level to the low-level. That is, in the second field, the state of **FIG. 3B** is established in the odd-numbered rows and the state of **FIG. 3A** is established in the even-numbered rows. The operation in the third field is the same as in the first field.

[0067] When attention is paid to a particular row, it is seen that the direction of an electric field applied to the liquid crystal capacitor element LC in the first field is in inverse to that in the second field. In this embodiment, the direction of electric fields applied to the liquid crystal capacitor elements LC of the even-numbered rows is in inverse to that of the odd-numbered rows; that is, the line inverting type driving is performed.

[0068] **FIG. 4** shows potentials of part of the matrix in a certain field. In **FIG. 4**, values shown in the matrix represent potentials of the associated pixel electrodes. As for the potentials of the common lines, $V_L=0$ V and $V_H=+5$ V. The scan lines are given a potential of -1 V in an off-state and +7 V in an on-state.

[0069] In **FIG. 4**, the pixels of the fourth row are being subjected to writing. Although the first and second rows display exactly the same image information, the directions of electric fields are in inverse in those rows. For example, with attention paid to the first-row/second column unit pixel and the second-row/second-column unit pixel, in the former unit pixel the potential of the pixel electrode is higher than

that of the common line with a potential difference of +4 V, whereas the latter unit pixel has a potential difference of -4 V. A similar relationship holds between other pairs of electrodes. In the fourth row under writing, the potentials of the data lines P_1 - P_4 are so set that the same image information as has been written to the third row is written to the fourth row (the directions of electric fields are in inverse).

Embodiment 3

[0070] Differences between the driving method of the invention and the conventional driving method will be described below with reference FIGS. 11A-11C. FIGS. 11A-11C show waveforms of the potentials of the scan line X_n , the data line P_m , and the common line Y_n that are connected to the pixel shown in FIG. 7. It is assumed that the field inverting scheme is employed. This embodiment employs a scheme in which an offset voltage V_{off} is always superimposed on the voltage that is applied to the pixel. In FIGS. 11A-11C, the potential V_X applied to the scan line X_n and the potential V_P of the data line P_m are expressed with overlapping on each other, the potential V_Y of the common line Y_n is drawn separately with V_C used as a reference potential when it varies over time (FIGS. 11B and 11C), to prevent the drawings from becoming unduly complex.

[0071] FIG. 11A shows the conventional driving method. The potential V_Y of the common line (or common electrode) Y_n is kept at the constant value V_C . The potential variation due to the image information itself is only V_{amp} . However, due to the offset voltage V_{off} , the potential V_P of the data line P_m has the maximum variation of $2(V_{amp}+V_{off})$. Accordingly, the height of selection pulses on the scan line X_n increases.

[0072] However, as a matter of fact, useless voltages are applied to the data line P_m . One of those voltages is the offset voltage V_{off} . The offset voltage V_{off} need not be supplied via the data line P_m . The potential variation of the data line P_m can be reduced by supplying the offset voltage V_{off} via the common line Y_n . FIG. 11B shows such a case.

[0073] What we should pay attention to is the potential difference applied to "the pixel in an off-state" rather than the potential difference between "the data line P_m and the common line Y_n ." Therefore, the offset voltage V_{off} is supplied to the common line Y_n in synchronism with the application of a selection pulse to the scan line X_n . In the example of FIG. 11B, the potential of the common line Y_n is changed to V_C immediately before the application of a selection pulse. The voltage based on only the image information is applied to the data line P_m .

[0074] In the above manner, the potential variation of the data line P_m can be reduced to $2V_{amp}$ and the selection pulse height can be reduced accordingly. It is apparent that the voltage applied to the pixel in an off-state is almost the same as in the conventional case.

[0075] However, even in the driving method of FIG. 11B, a useless voltage is still applied to the data line P_m , which is an inverted output for the alternating. To eliminate the inverting output, in the second field the data is given a bias of V_{amp} with respect to the data shown in FIG. 11B (also indicated by a broken line in FIG. 11C; this data is based on only the image information). With this measure, the potential variation of the data line P_m is reduced to V_{amp} .

[0076] Since the potential V_P of the data line P_m is biased by V_{amp} in the second field, the potential V_Y of the common line Y_n should also be increased by V_{amp} in the second field. If this is not the case, the polarity inversion is not effected properly. FIG. 11C is an example in which the potential variation of the data line P_m is decreased according to the above-described concept.

[0077] As described above, the potential variation of the data line P_m can be reduced to V_{amp} and the selection pulse height can be reduced accordingly. It is apparent that the voltage applied to the pixel in a non-selection state is exactly the same as in the case of FIG. 11B and almost the same as in the conventional case of FIG. 11A.

[0078] For example, if V_{off} and V_{amp} are respectively set at 2 V and 3 V and the selection pulse height is so set as to have a 2-V margin with respect to each of the minimum and maximum values of the potential V_P of the data line P_m , the potential variation range of the data line P_m is 10 V and the selection pulse height is 14 V in the conventional driving method of FIG. 11A.

[0079] On the other hand, the potential variation range of the data line P_m is 6 V and the selection pulse height is 10 V in the case of FIG. 11B. In the case of FIG. 11C, the potential variation range of the data line P_m and the selection pulse height can be reduced to 3 V and 7 V, respectively.

[0080] As described above, the invention can make the potential variation of data in half while enabling the directions of electric fields applied to liquid crystal capacitor elements to be inverted. As a result, the drive voltages of the data driver can be made a half of those in the conventional case, which is effective in reducing the power consumption. Further, the employment of the invention is advantageous also in the driving circuit of the scan driver and the transistors used in the active matrix circuit.

[0081] For example, in an active matrix circuit (see FIG. 7) employing the conventional driving method, if the potential of the electrode of the opposed substrate (or common lines) is set at a constant value, for instance, 0 V, and the variation range of the data for image display is 0 to 5 V, the potential of data that is output from the data driver varies from +5 V to -5 V (variation range: 10 V). That is, the source-drain potential difference of the transistors amounts to 10 V at the maximum.

[0082] To keep the transistors in an off-state during non-selection periods in a stable manner even under the above condition, the gate electrode potential of the transistors needs to be lower than $-5+V_{th}$ V (for NMOS transistors; higher than $5-V_{th}$ V for PMOS transistors). (The following description will be directed only to the case of NMOS transistors.)

[0083] Further, to keep the transistors in an on-state during selection periods in a reliable manner, the gate electrode potential of the transistors needs to be higher than $+5+V_{th}$ V.

[0084] In the above description of the embodiments, it is assumed that the threshold voltage V_{th} is +0.5 V and the margin is 1.5 V. Under the same conditions, the potentials to keep an off-state and an on-state should be -6 V and +7 V, respectively. In this case, the maximum source-drain potential difference and the maximum gate-source (or gate-drain) potential difference of the switching transistors amount to 10

V and 12 V, respectively. It is understood that an unduly heavy load as compared to the voltage (5 V) required from image information is imposed on the switching transistors. For this reason, high-breakdown-voltage transistors need to be used in the active matrix circuit.

[0085] The scan driver is also required to produce voltages ranging from -6 V to +7 V, i.e., having a potential difference (selection pulse height) of 13 V, which is unduly large. Further, the output potential difference of the data driver is 10 V.

[0086] In contrast, according to the invention, even if the same transistors are used to perform the same display as in the above case, the potential variation of data is from 0 V to 5 V (potential difference: 5 V) and the potential of the data line can be kept of the same polarity, as described in the above embodiments. Further, to keep the transistors in an off-state during non-selection periods in a stable manner, the gate electrode potential of the transistors may be set at about -1 V. To keep the transistors in an on-state during selection periods in a reliable manner, the gate electrode potential may be set at about +7 V. That is, the output potential difference (selection pulse height) of the scan driver is 8 V.

[0087] That is, according to the invention, the switching transistors of the active matrix circuit have the maximum source-drain potential difference of 5 V and the maximum gate-source (or gate-drain) potential difference of 7 V, for instance. The latter value is much smaller than the potential difference 12 V of the conventional case. Although the 5 V-decrease in potential difference may not appear to provide remarkable effects, it can sufficiently reduce the load of the transistors; that is, it is very effective in increasing the yield of transistors.

[0088] Experiments of the present inventors have proved that where a 1,200-Å-thick silicon oxide film is used as the gate-insulating film, a very small number of transistors are broken when, the gate-source voltage is smaller than 10 V, whereas once the gate-source voltage exceeds 10 V the number of broken transistors increases exponentially with every 1 V-increment. Thus, to make the gate-source voltage smaller than 10 V is very meaningful from the industrial viewpoint.

[0089] As described above, the invention enables the driving in which the potential of data varies from 0 V to 5 V, which means that the potential variation range is 5 V and the potential of the data line has a single polarity.

[0090] As a result, the invention allows the data driver to produce signals of a single polarity, in contrast to the fact that conventionally the data driver needs to supply polarity-inverting signals to the data lines to effect alternating.

[0091] Further, according to the invention, the height of selection pulses that are output from the scan driver is 8 V, which is smaller than the conventional value of 13 V. This means reduction in the load of the scan driver.

[0092] Thus, the invention can reduce the power consumption not only in the data driver but also in the scan driver, and can also reduce the load of the transistors used in the active matrix circuit. In particular, as long as the latter item is concerned, even transistors of a little low in quality are allowed to operate with sufficient performance.

[0093] The fact that the output voltages of the scan driver and the data driver can be reduced means that the load of the transistors used therein can also be reduced. This is particularly effective in what is called a monolithic active matrix circuit in which the scan driver and the data driver are incorporated in the same substrate as the active matrix circuit in an integral manner. This is because in a monolithic active matrix circuit thin-film transistors are generally used in the scan driver and the data driver as in the active matrix circuit and the thin-film transistors have a weakness of a low breakdown voltage.

[0094] Further, the reduction in selection pulse height leads to a reduction in the pixel-side voltage drop that is caused at the time of switching by the existence of a parasitic capacitor of the switching transistor (what is called a feedthrough voltage). This is because this voltage drop is proportional to the selection pulse height.

[0095] Although the above embodiments are directed to the case where n-channel transistors (NMOS transistors) are used, it goes without saying that the driving can be performed in the same manner even with p-channel transistors (PMOS transistors). Further, although the above embodiments are directed to the case of in-plane switching (IPS) mode, the present invention is not limited for the IPS device. Exhibiting various advantages when applied to active matrix liquid crystal display devices as described above, the invention is very useful from the industrial viewpoint.

What is claimed is:

1. A driving method for an active matrix display device of an in-plane switching mode comprising:

- a plurality of scan lines arranged so as not to intersect each other;
- a plurality of data lines arranged so as to cross said scan lines;
- a plurality of common lines arranged corresponding to respective scan lines so as not to cross said scan lines;
- a pixel capacitor element having a pair of electrodes, said pixel capacitor element being provided for each intersection of said scan lines and said data lines, one of said electrodes being connected to a corresponding one of said common lines; and
- a switching element comprising a control electrode and input and output terminals, said switching element being provided for each intersection of said scan lines and said data lines, said input terminal being connected to a corresponding one of said data lines, said output terminal being connected to the other of said electrodes of said pixel capacitor element, said control electrode being connected to a corresponding one of said scan lines, comprising the steps of:

keeping each of said common lines at potential being selected from V_H and V_L , where $V_H > V_L$, during almost all of a period when a selection pulse is not applied to a corresponding one of said scan lines; and

applying to said data lines a signal potential V_D where $V_L \leq V_D \leq V_H$.

* * * * *

专利名称(译)	有源矩阵显示装置的驱动方法		
公开(公告)号	US20060017679A1	公开(公告)日	2006-01-26
申请号	US11/166339	申请日	2005-06-27
[标]申请(专利权)人(译)	株式会社半导体能源研究所		
申请(专利权)人(译)	半导体能源研究所CO., LTD., 日本株式会社		
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IPC分类号	G09G3/36		
CPC分类号	G09G3/3614 G09G3/3648 G09G3/3655 G09G2330/04 G09G2300/0434 G09G2330/025 G09G3/3659		
优先权	1996096317 1996-03-26 JP		
其他公开文献	US7336249		
外部链接	Espacenet USPTO		

摘要(译)

在面内切换模式 (IPS模式) 的液晶显示装置中, 从数据驱动器输出的数据的电位被设定为给予公共线的电位之间的值。准备两个电平, 即高电平和低电平, 以便给予公共线的电位, 并且在每个场中的电平之间反转电位, 从而反转像素的两个电极之间的电压的极性。结果, 从传统情况的信号驱动器和扫描驱动器输出的信号的电位变化范围可以大大减小, 这有助于降低驱动器的功耗。由于可以减小施加到用于控制每个像素的开关元件的电压, 所以也可以减小开关元件的负载。

